DGG PACKAGE

SCAS575B - JULY 1996 - REVISED DECEMBER 2004

- Use CDCVF2510A as a Replacement for this Device
- **Phase-Lock Loop Clock Distribution for** Synchronous DRAM Applications
- **Distributes One Clock Input to Four Banks** of Four Outputs
- **Separate Output Enable for Each Output Bank**
- External Feedback Pin (FBIN) Is Used to Synchronize the Outputs to the Clock Input
- No External RC Network Required
- Operates at 3.3-V V_{CC}
- Packaged in Plastic 48-Pin Thin Shrink **Small-Outline Package**

description

The CDC516 is a high-performance, low-skew, low-jitter, phase-lock loop clock driver. It uses a phase-lock loop (PLL) to precisely align, in both frequency and phase, the feedback output (FBOUT) to the clock (CLK) input signal. It is specifically designed for use with synchronous DRAMs. The CDC516 operates at 3.3-V V_{CC} and is designed to drive up to five clock loads per output.

Four banks of four outputs provide 16 low-skew, low-jitter copies of the input clock. Output signal duty cycles are adjusted to 50 percent, independent of the duty cycle at the input clock. Each bank of outputs can be enabled or disabled separately via the 1G, 2G, 3G, and 4G control inputs. When the G inputs are high, the outputs switch in phase and frequency with CLK; when the G inputs are low, the outputs are disabled to the logic-low state.

(TOP VIEW) 48 🛮 V_{CC} V_{CC} 1Y0 47∐ 4Y0 1Y1 46 🛮 4Y1 GND I 🛚 GND 45 GND [44 GND 1Y2 43 ¶ 4Y2 1Y3 42 | 4Y3 V_{CC} 8 41 V_{CC} 1G 9 40 4G GND [39 GND 10 AV_{CC} 411 38 AV_{CC} CLK 12 37 FBIN AGND 113 36 ∏ AGND AGND 114 35 FBOUT GND 15 34 ∏ GND 2G II 16 33 ∏ 3G V_{CC} **∐**17 32 V_{CC} 2Y0 118 31 3Y0 2Y1 Π 30**∏** 3Y1 19 GND | 20 29 GND GND []21 28 ∏ GND 2Y2 22 27 3Y2 26 ¶ 3Y3 2Y3 | 23 25 🛮 V_{CC} 24 V_{CC}

Unlike many products containing PLLs, the CDC516 does not require external RC networks. The loop filter for the PLL is included on-chip, minimizing component count, board space, and cost.

Because it is based on PLL circuitry, the CDC516 requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This stabilization time is required following power up and application of a fixed-frequency, fixed-phase signal at CLK, as well as following any changes to the PLL reference or feedback signals. The PLL may be bypassed for test purposes by strapping AV_{CC} to ground.

The CDC516 is characterized for operation from 0°C to 70°C.



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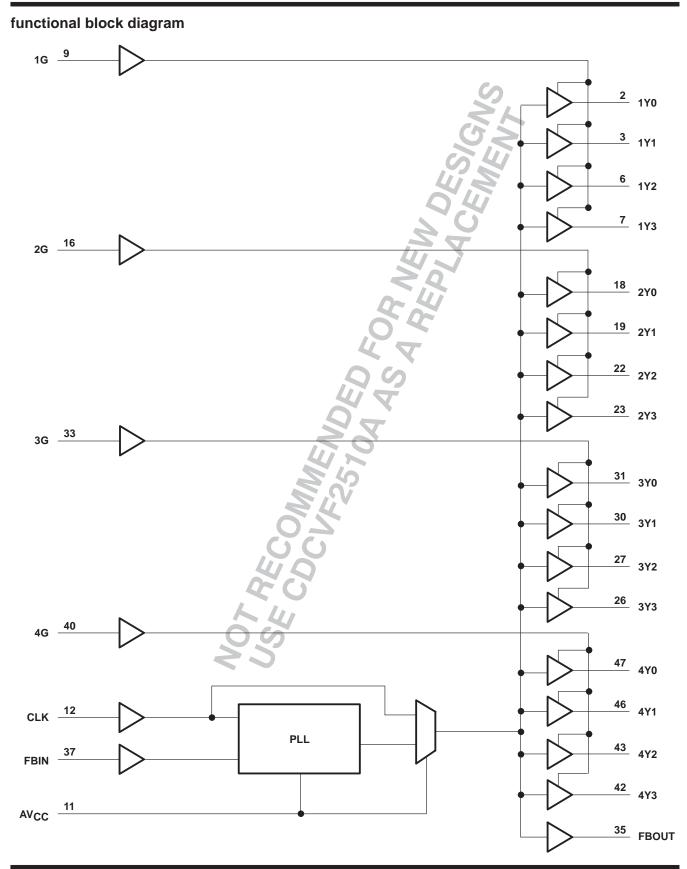
FUNCTION TABLE

		INPUTS					ОИТРИТ	s	
1G	2G	3G	4G	CLK	1Y (0:3)	2Y (0:3)	3Y (0:3)	4Y (0:3)	FBOUT
Х	Χ	Χ	Χ	L	L	L	L	Co	L
L	L	L	L	Н	L	L	L	1	Н
L	L	L	Н	Н	L	L	L	Н	Н
L	L	Н	L	Н	L	L	Н	L	Н
L	L	Н	Н	Н	L	L	HC	Н	Н
L	Н	L	L	Н	L	Н	L	L	Н
L	Н	L	Н	Н	L	Н	L	Н	Н
L	Н	Н	L	Н	L	Н	Н	L	Н
L	Н	Н	Н	Н	L	Н	H	Н	Н
Н	L	L	L	Н	Н	L	L	L	Н
Н	L	L	Н	Н	Н	L		Н	Н
Н	L	Н	L	Н	Н	L	H	L	Н
Н	L	Н	Н	Н	Н	L	Н	Н	Н
Н	Н	L	L	Н	Н	Н	L	L	Н
Н	Н	L	Н	Н	H	Н	L	Н	Н
Н	Н	Н	L	Н	Н	Н	Н	L	Н
Н	Н	Н	Н	Н	Ξ	Н	Н	Н	Н

AVAILABLE OPTIONS

	PACKAGE
TA	SMALL OUTLINE (PW)
0°C to 70°C	CDC516DGGR





Terminal Functions

TE	RMINAL		
NAME	NO.	TYPE	DESCRIPTION
CLK	12	I	Clock input. CLK provides the clock signal to be distributed by the CDC516 clock driver. CLK is used to provide the reference signal to the integrated PLL that generates the clock output signals. CLK must have a fixed frequency and fixed phase for the PLL to obtain phase lock. Once the circuit is powered up and a valid CLK signal is applied, a stabilization time is required for the PLL to phase lock the feedback signal to its reference signal.
FBIN	37	1	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN must be hard-wired to FBOUT to complete the PLL. The integrated PLL synchronizes CLK and FBIN so that there is nominally zero phase error between CLK and FBIN.
1G	9	I	Output bank enable. 1G is the output enable for outputs 1Y(0:3). When 1G is low, outputs 1Y(0:3) are disabled to a logic-low state. When 1G is high, all outputs 1Y(0:3) are enabled and switch at the same frequency as CLK.
2G	16	I	Output bank enable. 2G is the output enable for outputs 2Y(0:3). When 2G is low, outputs 2Y(0:3) are disabled to a logic-low state. When 2G is high, all outputs 2Y(0:3) are enabled and switch at the same frequency as CLK.
3G	33	I	Output bank enable. 3G is the output enable for outputs 3Y(0:3). When 3G is low, outputs 3Y(0:3) are disabled to a logic-low state. When 3G is high, all outputs 3Y(0:3) are enabled and switch at the same frequency as CLK.
4G	40	I	Output bank enable. 4G is the output enable for outputs 4Y(0:3). When 4G is low, outputs 4Y(0:3) are disabled to a logic-low state. When 4G is high, all outputs 4Y(0:3) are enabled and switch at the same frequency as CLK.
FBOUT	35	0	Feedback output. FBOUT is dedicated for external feedback. It switches at the same frequency as CLK. When externally wired to FBIN, FBOUT completes the feedback loop of the PLL.
1Y(0:3)	2, 3, 6, 7	0	Clock outputs. These outputs provide low-skew copies of CLK. Outputs 1Y(0:3) are enabled via 1G. These outputs can be disabled to a logic-low state by deasserting the 1G control input.
2Y(0:3)	18, 19, 22, 26	0	Clock outputs. These outputs provide low-skew copies of CLK. Outputs 2Y(0:3) are enabled via 2G. These outputs can be disabled to a logic-low state by deasserting the 2G control input.
3Y(0:3)	31, 30, 27, 26	0	Clock outputs. These outputs provide low-skew copies of CLK. Outputs 3Y(0:3) are enabled via 3G. These outputs can be disabled to a logic-low state by deasserting the 3G control input.
4Y(0:3)	47, 46, 43, 42	0	Clock outputs. These outputs provide low-skew copies of CLK. Outputs 4Y(0:3) are enabled via 4G. These outputs can be disabled to a logic-low state by deasserting the 4G control input.
AVCC	11, 38	Power	Analog power supply. AV_{CC} provides the power reference for the analog circuitry. In addition, AV_{CC} can be used to bypass the PLL for test purposes. When AV_{CC} is strapped to ground, the PLL is bypassed and CLK is buffered directly to the device outputs.
AGND	13, 14, 36	Ground	Analog ground. AGND provides the ground reference for the analog circuitry.
Vcc	1, 8, 17, 24, 25, 32, 41, 48	Power	Power supply
GND	4, 5, 10, 15, 20, 21, 28, 29, 34, 39, 44, 45	Ground	Ground



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage range, V _{CC}	0.5 V to 4.6 V
Input voltage range, V _I (see Note 1)	0.5 V to 6.5 V
Voltage range applied to any output in the high	
or low state, V _O (see Notes 1 and 2)	$1.000 - 0.5 \text{ V}$ to $V_{CC} + 0.5 \text{ V}$
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through each V _{CC} or GND	±100 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 3)	0.85 W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 4.6 V maximum.
 - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002.

recommended operating conditions (see Note 4)

		MIN	MAX	UNIT
Vcc	Supply voltage	3	3.6	V
VIH	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
loh	High-level output current		-20	mA
loL	Low-level output current		20	mA
TA	Operating free-air temperature	0	70	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST C	ONDITIONS	V _{CC}	MIN	TYP‡	MAX	UNIT
VIK	I _I = -18 mA	4.0	3 V			-1.2	V
V	I _{OH} = -100 μA	. 41	MIN to MAX	V _{CC} -0.2			
VOH	I _{OH} = -20 mA	6	3 V	2.4			V
\/-·	I _{OL} = 100 μA	MIN to MAX			0.2		
VOL	I _{OL} = 20 mA	3 V			0.55	V	
lį	$V_I = V_{CC}$ or GND		3.6 V			±5	μΑ
I _{CC} §	$V_I = V_{CC}$ or GND	$I_O = 0$, Outputs: low or high	3.6 V			20	μΑ
ΔlCC	One input at V _{CC} – 0.6 V,	Other inputs at V _{CC} or GND	3.3 V to 3.6 V			500	μΑ
C _i	$V_I = V_{CC}$ or GND		3.3 V		4	·	pF
Co	$V_O = V_{CC}$ or GND		3.3 V		6		pF

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[§] For ICC of AVCC, see Figure 5. For dynamic digital ICC, see Figure 6.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN	MAX	UNIT
fclock	Clock frequency	25	125	MHz
	Input clock duty cycle	40%	60%	
	Stabilization time†		1	ms

Time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. For phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK. Until phase lock is obtained, the specifications for propagation delay, skew, and jitter parameters given in the switching characteristics table are not applicable.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 30$ pF (see Note 5 and Figures 1 and 2)[‡]

PARAMETER	FROM	TO (OUTPUT)	V _{CC} = 3.3 V ± 0.165 V	,	V _{CC} = 3.3 V ± 0.3 V		
	(INPUT)	(OUTPUT)	MIN TYP MAX	MIN	TYP MAX		
^t phase error reference (see Figure 3)	66 MHz < CLKIN↑ < 100 MHz	FBIN↑	V S		-80400	ps	
^t phase error, – jitter, (see Note 6)	CLKIN↑ = 100 MHz	FBIN↑	170 360		240	ps	
t _{sk(o)} §	Any Y or FBOUT	Any Y or FBOUT			200	ps	
Jitter _(pk-pk)	F(clkin > 66 MHz)	Any Y or FBOUT	S	-100	100	ps	
	F(clkin ≤ 66 MHz)	Any Y or FBOUT		45%	55%		
Duty cycle	F(clkin > 66 MHz)	Any Y or FBOUT		43%	57%		
t _r		Any Y or FBOUT	1.1 1.5	0.7	1.6	ns	
t _f		Any Y or FBOUT	0.8 1.3	0.5	1.5	ns	

[‡] These parameters are not production tested.

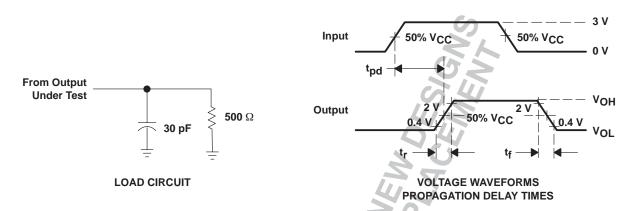


[§] The t_{sk(0)} specification is only valid for equal loading of all outputs.

NOTES: 5. The specifications for parameters in this table are applicable only after any appropriate stabilization time has elapsed.

^{6.} Phase error does not include jitter. The total phase error is 70 ps to 460 ps for the 5% V_{CC} range.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 100 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 1.2 ns. $t_f \leq$ 1.2 ns.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION

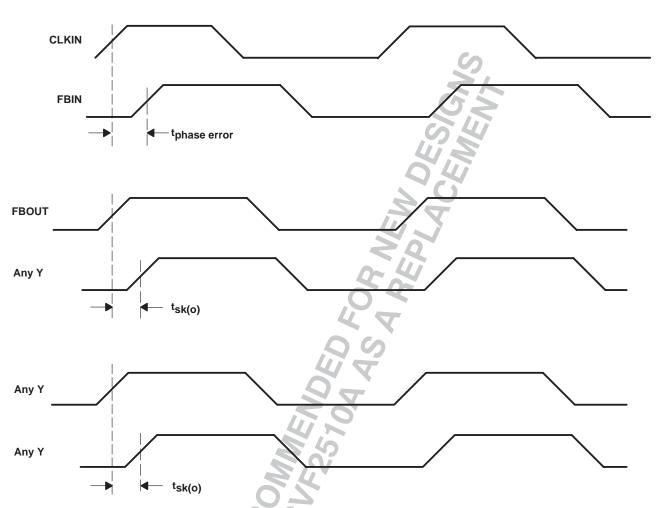


Figure 2. Phase Error and Skew Calculations



Figure 6

TYPICAL CHARACTERISTICS

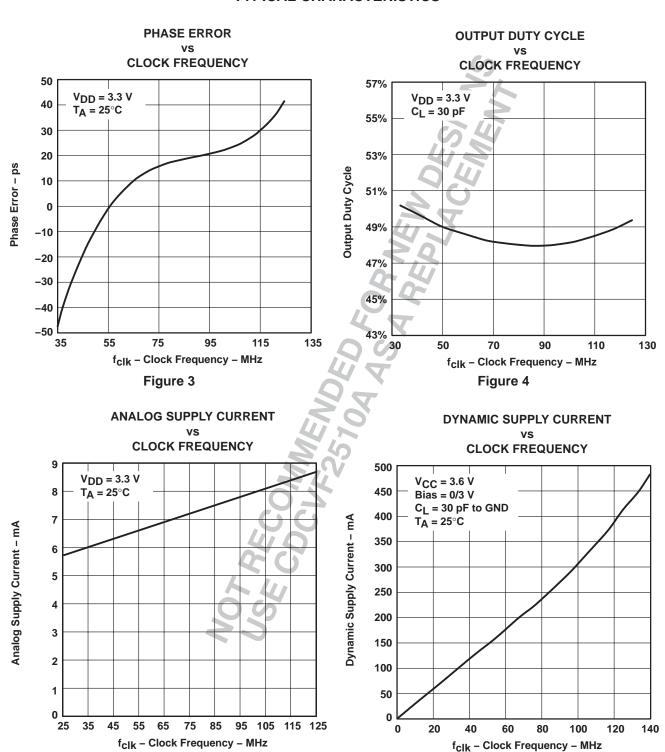


Figure 5

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
CDC516DGG	Active	Production	TSSOP (DGG) 48	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	CDC516
CDC516DGG.B	Active	Production	TSSOP (DGG) 48	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	CDC516
CDC516DGGG4	Active	Production	TSSOP (DGG) 48	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	CDC516
CDC516DGGR	Active	Production	TSSOP (DGG) 48	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	CDC516
CDC516DGGR.B	Active	Production	TSSOP (DGG) 48	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	CDC516

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

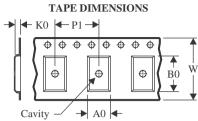
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

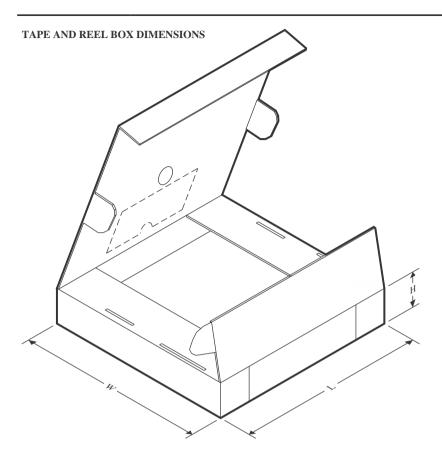


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	` '	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDC516DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1

PACKAGE MATERIALS INFORMATION

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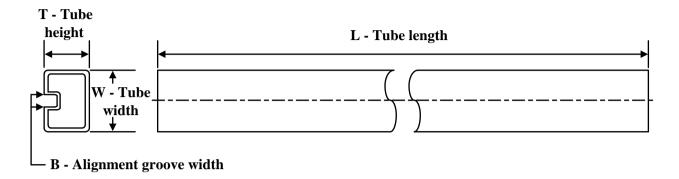
*All dimensions are nominal

	Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
I	CDC516DGGR	TSSOP	DGG	48	2000	356.0	356.0	45.0	

PACKAGE MATERIALS INFORMATION

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TUBE

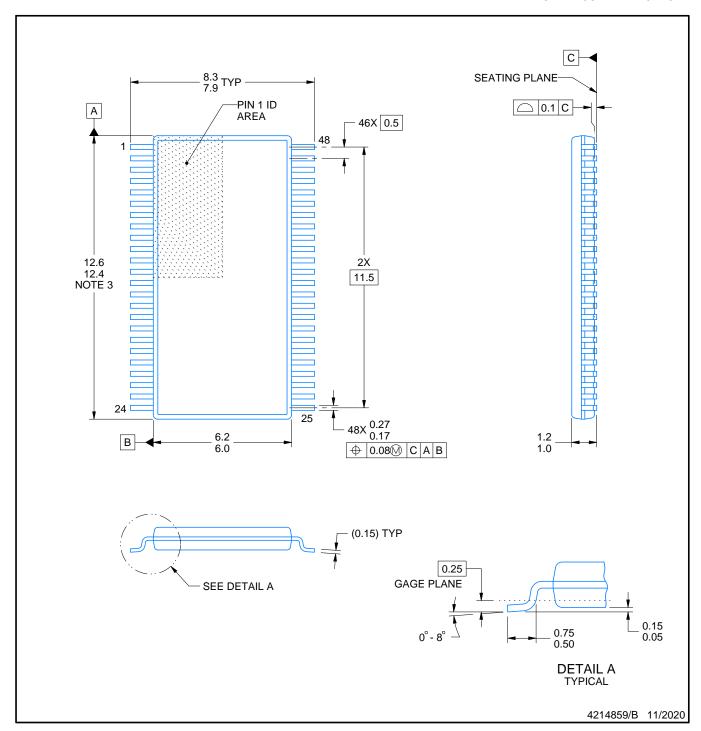


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CDC516DGG	DGG	TSSOP	48	40	530	11.89	3600	4.9
CDC516DGG.B	DGG	TSSOP	48	40	530	11.89	3600	4.9
CDC516DGGG4	DGG	TSSOP	48	40	530	11.89	3600	4.9



SMALL OUTLINE PACKAGE



NOTES:

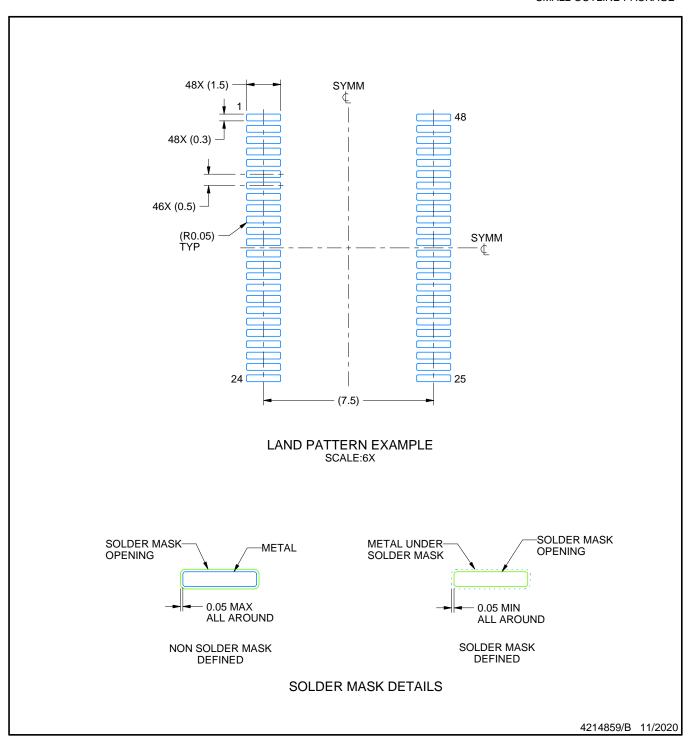
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE

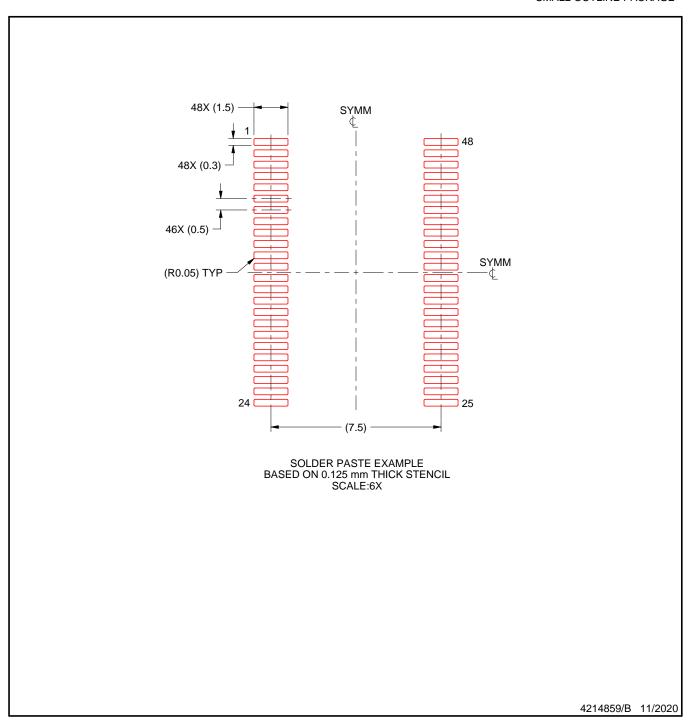


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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